Research Article

SiC Devices for Renewable and High Performance Power Conversion Applications

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The unique properties of SiC devices enable substantial improvement of existing power conversion systems. SiC devices offer lower conduction and switching losses which increases converter efficiency. With high switching speed ability, employing SiC is expected to reduce weight and cost of conversion systems. This paper investigates the potential impact of SiC devices on renewable energy applications.

1. Introduction

Renewable energy system designers have been striving to achieve higher efficiency and lower cost systems. These gains will translate directly into higher adoption of renewable energy sources. SiC devices offer, compared to silicon, a higher voltage devices with lower on-state resistance and faster switching speed. This boosts converter efficiency by reducing conduction and switching losses. For example, photovoltaic inverters can achieve smaller size, lighter weight, and more cost-effective designs utilizing SiC. For example, inverter based on SiC JFET and Schottky diode has achieved efficiency up to 99% [1]. With such developments, solar energy price can be brought to comparative price level with conventional energy source. The high efficiency and cost effective SiC-based solution also benefits other applications including wind power and hybrid vehicle. Along with SiC, GaN is another wide band-gap material that gained a lot of research interest in the last decade. GaN-based MOSFETs with extremely low on-resistance are already reported [2, 3]. These developments in wide band-gap transistors are expected to dominate the ever-growing renewable energy production systems in the near future.

2. SiC Technology and State-of-the-Art

2.1. Introduction. Due to the high critical electrical field for breakdown, SiC devices feature higher breakdown voltage. This high critical electric filed (ten times higher than silicon) allows for thinner devices and thus lower on-resistance. Moreover, SiC has the capability of high-temperature operation without sacrificing the switching speed or significantly increasing conduction loss, all of which make them very potential in the high-power, high-voltage, high-frequency, and high-density applications. This fits the requirements of renewable energy applications. However, methods of driving some of these devices, for example, JFET, are different from the conventional Si-MOSFET or BJT. Therefore, the acceptance of this type of devices depends on the understanding of its switching behaviour and the ability to design a proper driving circuit.

2.2. SiC Devices. Several SiC devices were demonstrated. Unipolar devices combine fast switching speed with low on-state loss. However, as device blocking voltage increases (>3 kV), resistive voltage drop over the device drift region prohibitively increases. Hence, these devices are suitable
for medium voltage applications. Among unipolar devices Schottky diodes, JFETs, and MOSFETs are available. Schottky barrier diodes (SBDs) are made by utilizing the rectifying contact between a metal and device drift region. In case of silicon the high resistance of the drift region limits realizing high breakdown voltage devices and thus available devices are limited to 100 V. In the case of SiC, the higher breakdown field leads to lower drift region resistance. This enables higher breakdown voltages with lower losses making SiC-SBDs with breakdown voltage of 600–1700 V achievable. With the continuous development of the Schottky rectifiers, specific on-state resistance is already approaching the theoretical unipolar limit of SiC. Figure 1 shows some reported didoes with remarkably low on-resistance [4–6]. Nowadays, SBDs are commercially available from several manufactures, for example, Cree, Infineon, SemiSouth, STMicroelectronics, and Rohm.

JFET combines low on-state resistance with fast switching speed. Moreover, this device is free from reliability issues related to the gate oxide and temperature-dependent threshold voltages drifts. These reasons have made JFET one of the most successful devices within SiC technology [7]. The JFET is conventionally fabricated as a normally-on device. However, normally-off characteristic is achievable especially with the high built-in voltage (∼3 V) observed at SiC pn junction. Recent reported JFETs with 1.2 kV breakdown voltage have specific on-resistance of only 2.47 mΩcm² and 2.9 mΩcm² for normally-on and normally-off devices, respectively [8]. On the other hand, MOSFETs are preferred by designers due to high input impedance and voltage-controlled gate. So the efforts are continuing to realize a SiC-MOSFET with acceptable channel mobility and oxide reliability. Improving the interface between oxide and SiC is essential for increasing effective channel mobility and hence reducing device resistance. Double-implanted 4H-SiC MOSFET reports a channel mobility of 20 cm²/V.s for 1 kV device resulting in specific on-resistance as low as 6.95 mΩcm² [9].

For high breakdown voltages, bipolar devices offer low forward voltage drop. For voltages higher than 3 kV, SiC PiN diodes offer, in addition to the low forward voltage drop, a faster switching speed making them a good candidate to replace silicon PiN diodes in this voltage class. Unlike Si bipolar junction transistors, SiC BJTs can be made with a thinner base region increasing the device current gain (β). A power BJT with β as high as 134 was demonstrated [10]. Recently, 1200 V breakdown voltage BJTIs are commercially available from TranSiC [11].

Figure 1 shows the latest achievements of various SiC devices. It is evident that the significant reduction of devices specific on-state resistance will be reflected as an increase on converter efficiency.

3. SiC Properties for Renewable Energy Applications

The superior properties of SiC semiconductor have made it a material of choice for the new generation of power devices. Power devices with switching and conduction characteristics that are closer to ideal switch are being realised using SiC. In addition, the development of such devices impacts many aspects of converter performance and design. Main properties that influence converter design especially for renewable energy sources can be summarised as following.

(i) Low on-resistance: the lower resistance of the devices results in a lower conduction loss and thus a higher converter efficiency.

(ii) Low switching loss: the fact that SiC switches are capable of switching faster keeping a low switching energy loss implies an improvement of converter efficiency. Moreover, it enables higher switching frequency operation. This leads to smaller and lighter passive elements, that is, inductor and capacitors, increasing the power density of the conversion unit.

(iii) High blocking voltage capability: this is particularly promising for renewables with high power rates such as wind energy. Excising solutions are mostly based on medium DC link voltage (∼700 V) making use of step-up transformer unavoidable for grid connection purpose. Transformerless direct drive-wind generator can reduce nacelle weight as well as increase system efficiency and reliability [12]. With megawatt wind turbine, generators with high output voltage (<20 kV) could be employed. SiC-based power conditioning unit (AC-DC-AC) can be design for higher DC link voltages with the help of SiC-GTO or SiC-IGBT technologies. The high blocking voltage of these devices allows for simple and yet more reliable converter design. For example, three-phase inverter using a single high voltage device replaces multi-level converter or the need for

![Figure 1: Specific on-state resistance of recent SiC power device, where □ MOSFET, ▲ SBD, ○ normally-on JFET, and • normally-off JFET.](image-url)
connecting several devices in series will simplify the converter design and control. This is also beneficial for applications where high DC-link voltage is needed like those found in utility and traction applications.

(iv) High operating temperature: theoretically, SiC devices can operate at junction temperatures up to 700°C before its pn junction becomes nonfunctional. However, existing packaging technology prevents such high operating temperature. The highest reported temperature for full SiC converter built utilizing JFETs and SBDs is 400°C [13]. It is important to note here that the high temperature capability has another advantage that it decreases the system heat management demands. For example, this can lead to the use of a smaller heat sink size or facilitate the use of a high temperature coolant cycle, which already exists in the system, like combining converter and engine cooling cycles in a hybrid vehicle system.

4. SiC JFET for Renewable Applications

4.1. Device Characterization. The device characterized in the following is an enhancement-mode normally-off vertical JFET [14]. The device has a blocking voltage capability of 1200 V with maximum datasheet on-resistance of only 63 mΩ. The JFET structure is free from oxide interfaces that have reliability issues and cause low channel resistivity. Figure 2 shows a cross-sectional view of an enhancement-mode vertical SiC JFET. The device exhibits a normally-off characteristic. This is achieved by p-type gate region implantation (in n-type channel device) that is totally depleted at zero gate voltage, full fabrication details are given in [15]. Having a voltage controlled gate, SiC JFET is potential replacement of Si MOSFET and IGBT. Parasitic elements of this structure are also shown in Figure 2. Gate-source region forms a pn diode. Turning this diode on by applying a positive gate voltage, that consequently leads the depletion region to shrink, is the main requirement for turning on the JFET. Moreover, the parasitic capacitances (Cgs, Cgd, and Cds) affect switching speed. The SiC JFET has no internal body diode so external diode is needed for most applications.

Resistance of drain-source region, usually referred to as on-resistance, is an important performance measure. Thanks to SiC high critical field, this resistance can be dramatically reduced by achieving high blocking voltage with relatively higher doped and thinner drift region, compared to Si.

Measured on-resistance of the JFET at different temperatures is shown in Figure 3. This increase in device resistance is due to mobility degradation at the main temperatures. In addition, device on-resistance changes with gate voltage. In the case of Figure 3, resistance is measured at gate voltage of 2.65 V.

4.2. Dynamic Characterization. SiC JFET gate has relatively a low threshold voltage, that is, (~1 V), which makes gate less immune to noise, especially induced voltages across the gate connections. In addition, device gate-source region structure, which is basically a pn-junction, requires more attention when designing the driver. The basic driver requirement is the ability to keep device gate-source diode (Dgs) forwardly biased during the intended on period. Although JFET switching speed in solely determined by its parasitic capacitors, driver ability to charge/discharge these capacitors during on/off transition has a significant influence on switching speed. Improving the dynamic of the driver is done by employing the concept of two-stage driver. The two-stage driver fulfills the requirements of driving SiC JFET by quickly providing a charging current for input capacitances (Cgd + Cgs). This is done by a short gate voltage pulse design to ensure device entering on-state period and lowering on-state resistance without passing excessive current through Dgs. Such current can destroy gate region. The first stage is followed be a lower voltage stage (typically ~3 V). This second stage lasts during intended on period. It keeps Dgs forwardly biased and thus the device. In the same time this keeps the gate current at very low level resulting in lower driver losses. The driver circuit is also ensuring a fast turn-off by discharging device capacitances. With negative voltage level during the off-period, gate immunity to noise
can be improved and unwanted turn-on is avoidable. In addition, adding an external capacitance across gate-source will help increasing this immunity. Designing gate driver is challenging due to low threshold voltage and induced gate voltages as a result of overshoots in voltage and current waveforms at high switching speed. It is therefore important to use twisted conductor to connect driver circuit with device gate.

Figures 4 and 5 show turn-on and turn-off oscillograms. Switching waveforms are recorded during a standard double pulse test with clamped inductive load performed at drain-source voltage $V_{ds} = 500$ V and drain current $I_d = 15$ A with gate resistance $R_g = 3.5 \, \Omega$. A SiC Schottky diode was used as a clamping diode. The test facilitates characterising the dynamic characteristics of the device where switching times and energies can be measured. This test emulates hard switching conditions such as grid connected inverters and motor drives.

The recorded turn-on and turn-off times are 48 nsec and 56 nsec, respectively. These values demonstrate device ability for fast switching. However, the fast switching speed makes the converter operation very sensitive to circuit layout. Optimized layout is necessary to avoid any EMI problems related to this fast switching. For example, stray inductance should be minimized to avoid unwanted oscillation at high $di/dt$. The test setup used here utilizes multilayer PCB with strip conductor keeping distances between DC-link capacitor and device terminals minimal. Stray inductance appears at the JFET drain acts as a turn-on snubber causing a longer turn-on transition.

4.3. Switching Loss. Due to fast switching speed and the unipolar operation, SiC JFET is expected to have low switching losses. Figure 6 shows the device turn-on energy ($E_{on}$), turn-off energy ($E_{off}$), and total switching energy versus drain current. Switching energies are calculated by integrating power loss waveform during turn-on and turn-off periods. The test is performed with $V_{ds} = 500$ V and an ambient temperature of $25^\circ$C. The recorded $E_{on}$ and $E_{off}$ at drain current of 15 A were 62 $\mu$J and 181 $\mu$J, respectively. Total energy loss witnesses a slight increase as junction temperature increases. An increase of only 3% of total energy loss was recorded at temperature of $150^\circ$C.

To theoretically evaluate potential inverter efficiency, device power loss is estimated based on datasheet and measurement values. Equations used for this loss estimation are given in [16]. Total power dissipation of a three-phase inverter configuration uses SiC JFETs and Schottky diodes is shown in Figure 7. This calculation assumes an inverter with a DC-link voltage of 500 V and output peak current of 15 A. During this calculation of power dissipation, switching, conduction and driver circuit losses were included. SiC JFET demonstrates the ability to operate at higher switching frequency with acceptable efficiency. The total power loss of the inverter is compared when the SiC JFET is replaced with the state-of-the-art Si IGBT (IKW15T120) from Infineon [17]. The device has the same voltage rating of 1200 V as well as current rating of 15 A. By comparing the total power losses of the two inverters, the losses are higher in case of Si IGBT is used. Moreover, power losses increases prohibitively with the switching frequency. So, employing the SiC JFET in inverter design will improve efficiency and enables high
switching frequency operation. Solar inverters can highly benefit from these characteristics which are expected to bring energy cost down by reducing the weight and the size of both passive elements (inductance and capacitance) and the heat sink. This in return will increase market acceptance of this energy resource. Other high performance conversion systems such as hybrid vehicle, electric vehicle, and auxiliary power supply will also benefit from the demonstrated features of SiC devices.

5. Conclusions

In this paper a review of SiC devices status and impact on renewable energy applications is given. The needs of renewable energy conversion systems, such as inverter used in solar and wind applications, were matched to the superior features offered by SiC devices. The focus is on one of the most successful SiC devices, namely, JFET. The device combines low conduction and switching losses with fast switching capability. This makes it a candidate for high efficiency conversion systems. By increasing the switching frequency, the weight, size and cost of passive elements can be reduced. Moreover, device ability to operate at higher temperatures enables designs with reduced heat sink size and thus further increase in power density. These features are expected to reduce the cost of renewable energy systems which eventually will lead to more market acceptance of renewable energy sources.

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References
